

# ST93003

# HIGH VOLTAGE FAST-SWITCHING PNP POWER TRANSISTOR

- MEDIUM VOLTAGE CAPABILITY
- LOW SPREAD OF DYNAMIC PARAMETERS
- MINIMUM LOT-TO-LOT SPREAD FOR RELIABLE OPERATION
- VERY HIGH SWITCHING SPEED

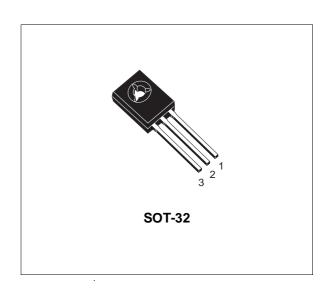
#### **APPLICATIONS:**

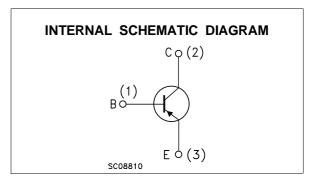
 ELECTRONIC BALLASTS FOR FLUORESCENT LIGHTING

#### **DESCRIPTION**

The device is manufactured using high voltage Multi-Epitaxial Planar technology for high switching speeds and medium voltage capability. It uses a Cellular Emitter structure with planar edge termination to enhance switching speeds while maintaining the wide RBSOA.

The ST93003 is expressly designed for a new solution to be used in compact fluorescent lamps, where it is coupled with the ST83003, its complementary NPN transistor.





#### **ABSOLUTE MAXIMUM RATINGS**

Symbol	Parameter	Value	Unit
V <sub>CES</sub>	Collector-Emitter Voltage (V <sub>BE</sub> = 0)	-500	V
$V_{CEO}$	Collector-Emitter Voltage (I <sub>B</sub> = 0)	-400	V
$V_{EBO}$	Emitter-Base Voltage	$V_{(BR)EBO}$	V
	$(I_C = 0, I_B = -0.75 \text{ A}, t_p < 10\mu\text{s}, T_j < 150^{\circ}\text{C})$		
Ic	Collector Current	-1.5	Α
I <sub>CM</sub>	Collector Peak Current (t <sub>p</sub> < 5 ms)	-3	А
$I_{B}$	Base Current	-0.75	А
I <sub>BM</sub>	Base Peak Current (t <sub>p</sub> < 5 ms)	-1.5	Α
P <sub>tot</sub>	Total Dissipation at T <sub>c</sub> = 25 °C	40	W
T <sub>stg</sub>	Storage Temperature	-65 to 150	°C
Tj	Max. Operating Junction Temperature	150	°C

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# THERMAL DATA

R <sub>thj-case</sub>	Thermal Resistance Junction-case	Max	3.12	°C/W
$R_{thj-amb}$	Thermal Resistance Junction-ambient	Max	89	°C/W

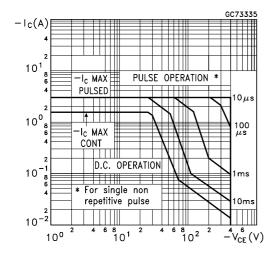
# **ELECTRICAL CHARACTERISTICS** (T<sub>case</sub> = 25 °C unless otherwise specified)

Symbol	Parameter	Test	Test Conditions		Тур.	Max.	Unit
I <sub>CES</sub>	Collector Cut-off Current (V <sub>BE</sub> = 0)	V <sub>CE</sub> = -500V V <sub>CE</sub> = -500V	$T_j = 125^{\circ}C$			-1 -5	mA mA
V <sub>(BR)EBO</sub>	Emitter Base Breakdown Voltage (Ic = 0)	I <sub>E</sub> = -10 mA		-5		-10	V
V <sub>CEO(sus)</sub> *	Collector-Emitter Sustaining Voltage (I <sub>B</sub> = 0)	I <sub>C</sub> = -10 mA L = 25 mH		-400			V
V <sub>CE(sat)</sub> *	Collector-Emitter Saturation Voltage	I <sub>C</sub> = -0.5 A I <sub>C</sub> = -0.35 A	I <sub>B</sub> = -0.1 A I <sub>B</sub> = -50 mA			-0.5 -0.5	V V
V <sub>BE(sat)</sub> *	Base-Emitter Saturation Voltage	I <sub>C</sub> = -0.5 A	I <sub>B</sub> = -0.1 A			-1	V
h <sub>FE</sub> *	DC Current Gain	$I_C = -10 \text{ mA}$ $I_C = -0.35 \text{ A}$ $I_C = -1 \text{ A}$	V <sub>CE</sub> = -5 V V <sub>CE</sub> = -5 V V <sub>CE</sub> = -5 V	10 16 4	25	32	
t <sub>r</sub> t <sub>s</sub> t <sub>f</sub>	RESISTIVE LOAD Rise Time Storage Time Fall Time	$I_{C} = -0.35 \text{ A}$ $I_{B1} = -70 \text{ mA}$ $T_{p} \ge 25 \mu\text{s}$	$V_{CC} = 125 V$ $I_{B2} = 70 \text{ mA}$ (see Figure 2)	1.5	90 2.2 0.1	2.9	ns µs µs
t <sub>s</sub>	INDUCTIVE LOAD Storage Time Fall Time	$I_C = -0.5 A$ $V_{BE(off)} = 5 V$ $V_{clamp} = 300 V$	$I_{B1} = -0.1 A$ L = 10 mH (see Figure 1)		400 40		ns ns
E <sub>sb</sub>	Avalanche Energy	$L = 4 \text{ mH}$ $I_{BR} \le 2.5 \text{ A}$	C = 1.8  nF $25^{\circ}\text{C} < \text{T}_{\text{C}} < 125^{\circ}\text{C}$	12			mJ

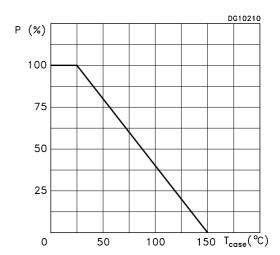
<sup>\*</sup> Pulsed: Pulse duration = 300μs, duty cycle = 1.5 %

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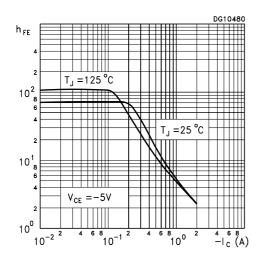
# Safe Operating Area



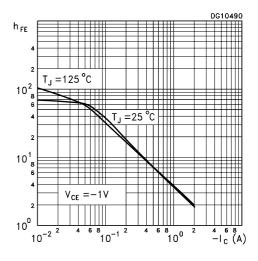
# **Derating Curve**



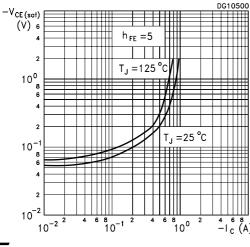
#### DC Current Gain



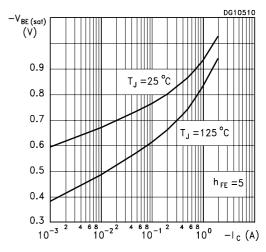
DC Current Gain



# Collector Emitter Saturation Voltage

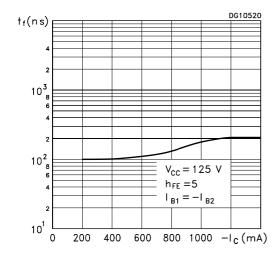


Base Emitter Saturation Voltage

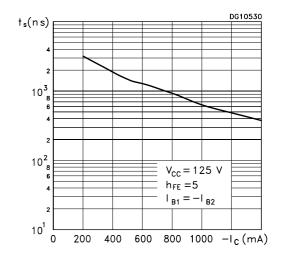


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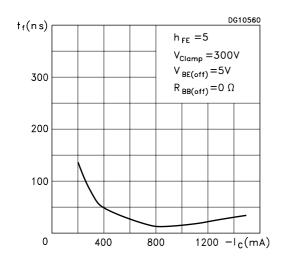
#### Resistive Fall Time



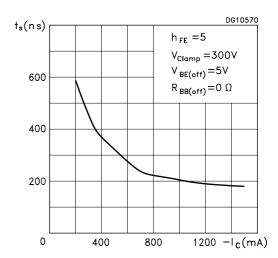
# Resistive Storage Time



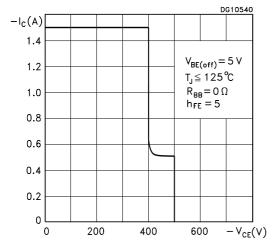
#### Inductive Fall Time



# Inductive Storage Time



#### Reverse Biased SOA



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Figure 1: Inductive Load Switching Test Circuit.

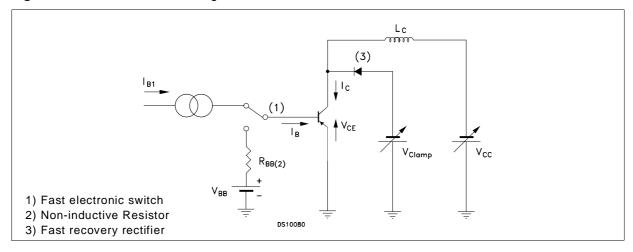
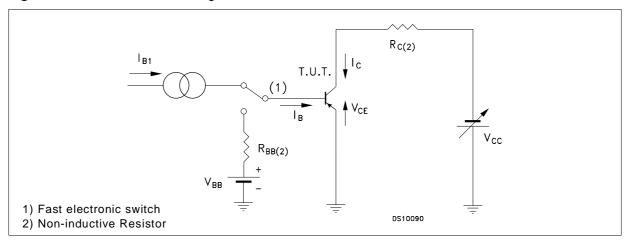
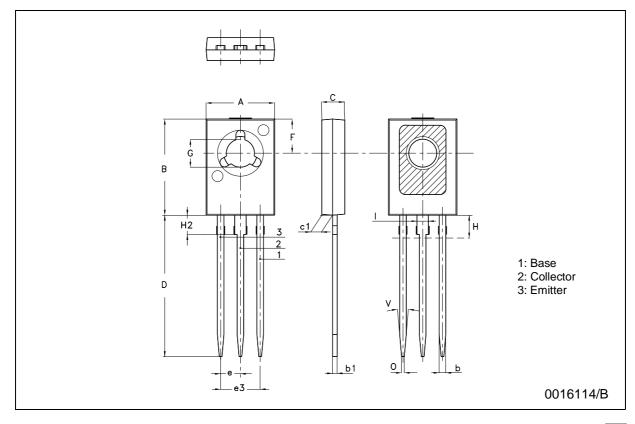


Figure 2: Resistive Load Switching Test Circuit.



# SOT-32 (TO-126) MECHANICAL DATA

DIM.	mm			inch			
DIIVI.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	
А	7.4		7.8	0.291		0.307	
В	10.5		10.8	0.413		0.425	
b	0.7		0.9	0.028		0.035	
b1	0.40		0.65	0.015		0.025	
С	2.4		2.7	0.094		0.106	
c1	1.0		1.3	0.039		0.051	
D	15.4		16.0	0.606		0.630	
е		2.2			0.087		
e3		4.4			0.173		
F		3.8			0.150		
G	3		3.2	0.118		0.126	
Н			2.54			0.100	
H2		2.15			0.084		
I		1.27			0.05		
0		0.3			0.011		
V		10°			10°		



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